

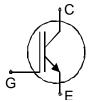
# High Speed IGBT Chip in NPT-technology

#### **FEATURES:**

- low Eoff
- 600V NPT technology
- 100µm chip
- short circuit prove
- positive temperature coefficient
- easy paralleling

# This chip is used for:

SKB06N60HS



## Applications:

- Welding
- PFC
- UPS

Chip Type	V <sub>CE</sub>	I <sub>Cn</sub>	Die Size	Package	Ordering Code	
SIGC07T60UN	600V	6A	2.6 x 2.6 mm <sup>2</sup>	sawn on foil	Q67050-A4220-	
516607 10001N	000		2.0 X 2.0 IIIIII	Sawii Oii ioii	A101	

# **MECHANICAL PARAMETER:**

Raster size	2.6 x 2.6				
Area total / active	6.8 / 4.1				
Emitter pad size	1.78 x 1.1				
Gate pad size	0.499 x 0.699				
Thickness	100	μm			
Wafer size	150	mm			
Flat position	180	deg			
Max.possible chips per wafer	2292				
Passivation frontside	Photoimide				
Emitter metallization	3200 nm Al Si 1%				
Collector metallization	1400 nm Ni Ag -system suitable for epoxy and soft solder die bonding				
Die bond	electrically conductive glue or solder				
Wire bond	AI, ≤500μm				
Reject Ink Dot Size	Ø 0.65mm ; max 1.2mm				
Recommended Storage Environment	store in original container, in dry nitrogen, < 6 month at an ambient temperature of 23°C				



#### **MAXIMUM RATINGS:**

Parameter	Symbol	Value	Unit
Collector-emitter voltage, T <sub>j</sub> =25 °C	V <sub>CE</sub>	600	V
DC collector current, limited by T <sub>jmax</sub>	I <sub>C</sub>	1)	А
Pulsed collector current, t <sub>p</sub> limited by T <sub>jmax</sub>	I <sub>cpuls</sub>	18	А
Gate emitter voltage	V <sub>GE</sub>	±20	V
Operating junction and storage temperature	$T_j$ , $T_{stg}$	-55 <b>+</b> 150	°C

<sup>1)</sup> depending on thermal properties of assembly

# **STATIC CHARACTERISTICS** (tested on chip), $T_i$ =25 °C, unless otherwise specified:

Parameter	Symbol	Conditions	Value			Unit
Turumeter		Conditions	min.	typ.	max.	
Collector-emitter breakdown voltage	V <sub>(BR)CES</sub>	$V_{GE}$ =0V, $I_{C}$ =500 $\mu$ A	600			
Collector-emitter saturation voltage	V <sub>CE(sat)</sub>	V <sub>GE</sub> =15V, I <sub>C</sub> =6A		2.8	3.15	V
Gate-emitter threshold voltage	$V_{\rm GE(th)}$	$I_C$ =200 $\mu$ A, $V_{GE}$ = $V_{CE}$	3	4	5	
Zero gate voltage collector current	I <sub>CES</sub>	V <sub>CE</sub> =600V, V <sub>GE</sub> =0V			0.7	μΑ
Gate-emitter leakage current	I <sub>GES</sub>	V <sub>CE</sub> =0V, V <sub>GE</sub> =20V			100	nA

## **DYNAMIC CHARACTERISTICS** (tested at component):

Parameter	Symbol	Conditions	Value			Unit
raiametei			min.	typ.	max.	]
Input capacitance	Ciss	V <sub>CE</sub> =25V	-	350		pF
Output capacitance	Coss	<i>V</i> <sub>GE</sub> =0∨ <i>f</i> =1MHz	-	50		
Reverse transfer capacitance	Crss	7-1111112	-	23		

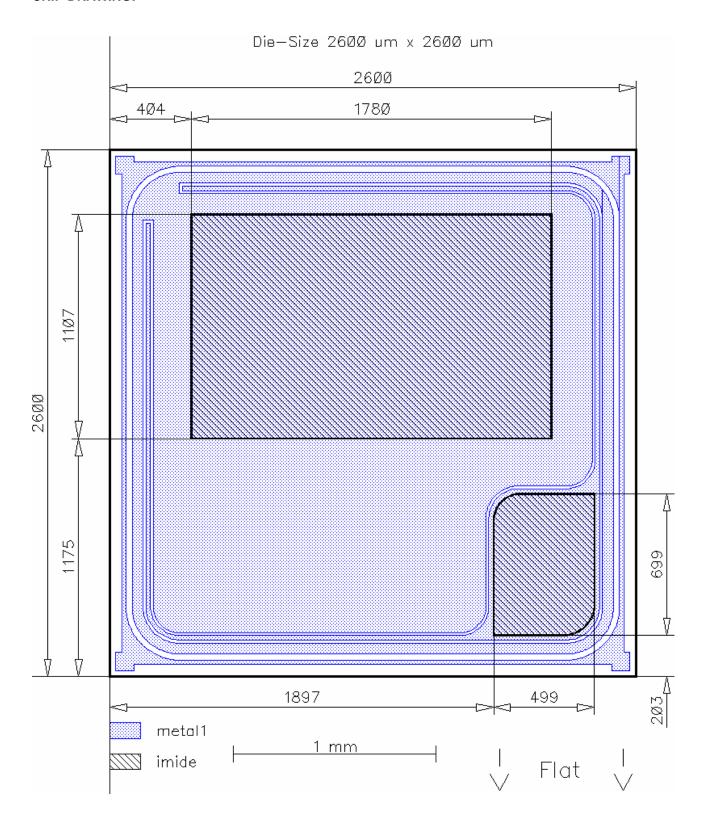
## **SWITCHING CHARACTERISTICS** (tested at component), Inductive Load:

Parameter	Symbol	Conditions 2)	Value			Unit
raiailietei			min.	typ.	max.	Onne
Turn-on delay time	$t_{d(on)}$	<i>T</i> <sub>j</sub> =150°C	-	8		ns
Rise time	t <sub>r</sub>	$V_{\rm CC} = 400 \text{V}$	-	3		
Turn-off delay time	$t_{d(off)}$	$I_{\rm C}$ =6A $V_{\rm GE}$ =+15/0V	-	63		
Fall time	$t_{f}$	$R_{\rm G}$ = 8 $\Omega$	-	59		

 $<sup>^{\</sup>rm 2}$  ) values also influenced by parasitic L- and C- in measurement and package.



#### **CHIP DRAWING:**





#### **FURTHER ELECTRICAL CHARACTERISTICS:**

This chip data sheet refers to the device data sheet SKB06N60HS Package :TO220

#### **Description:**

AQL 0,65 for visual inspection according to failure catalog

Electrostatic Discharge Sensitive Device according to MIL-STD 883

Test-Normen Villach/Prüffeld

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